			W
	Application No.	Applicant(s)	
Notice of Allowability	09/909,277	GALE ET AL.	
Notice of Allowability	Examiner	Art Unit	
	Gentle E. Winter	1746	
The MAILING DATE of this communication apperatus allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RI of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in or other appropriate comm GHTS. This application is :	n this application. If not include unication will be mailed in due	ed course <b>THIS</b>
1. This communication is responsive to <u>04/20/04</u> .			
2. The allowed claim(s) is/are 1,3-23 and 25-34 (renumbered	<u>as 1-32)</u> .		
3. The drawings filed on are accepted by the Examiner			
<ul> <li>4. ☐ Acknowledgment is made of a claim for foreign priority un</li> <li>a) ☐ All b) ☐ Some* c) ☐ None of the:</li> <li>1. ☐ Certified copies of the priority documents have</li> <li>2. ☐ Certified copies of the priority documents have</li> <li>3. ☐ Copies of the certified copies of the priority documents have</li> <li>International Bureau (PCT Rule 17.2(a)).</li> <li>* Certified copies not received:</li> </ul>	been received. been received in Application	on No	tion from the
Applicant has THREE MONTHS FROM THE "MAILING DATE" on noted below. Failure to timely comply will result in ABANDONM THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.	of this communication to file ENT of this application.	e a reply complying with the rec	quirements
5. A SUBSTITUTE OATH OR DECLARATION must be submit INFORMAL PATENT APPLICATION (PTO-152) which give	tted. Note the attached EX	AMINER'S AMENDMENT or N r declaration is deficient.	OTICE OF
6. CORRECTED DRAWINGS ( as "replacement sheets") mus	t be submitted.		
(a) including changes required by the Notice of Draftsperson		v (PTO-948) attached	
1) 🗌 hereto or 2) 🔲 to Paper No./Mail Date			
(b) including changes required by the attached Examiner's Paper No./Mail Date	Amendment / Comment or	in the Office action of	
Identifying indicia such as the application number (see 37 CFR 1. each sheet. Replacement sheet(s) should be labeled as such in the	84(c)) should be written on the header according to 37 CF	he drawings in the front (not the R. 1.121(d).	back) of
<ol> <li>DEPOSIT OF and/or INFORMATION about the deposit attached Examiner's comment regarding REQUIREMENT F</li> </ol>	SIT OF BIOLOGICAL MATE FOR THE DEPOSIT OF BIO	ERIAL must be submitted. N DLOGICAL MATERIAL.	Note the
Attachment(s)  1. ☐ Notice of References Cited (PTO-892)  2. ☐ Notice of Draftperson's Patent Drawing Review (PTO-948)  3. ☐ Information Disclosure Statements (PTO-1449 or PTO/SB/04 Paper No./Mail Date  4. ☐ Examiner's Comment Regarding Requirement for Deposit of Biological Material	6. ⊠ Interview S Paper No./ 3), 7. ⊠ Examiner's	formal Patent Application (PTC ummary (PTO-413), /Mail Date <u>042004</u> . Amendment/Comment Statement of Reasons for Allo	·

Application/Control Number: 09/909,277

Art Unit: 1746

#### **DETAILED ACTION**

# Claim Rejections - 35 USC § 112--Withdrawn

Applicant sought clarification of 112 first paragraph rejection and suggested that support for the claim language could be found in the first lines of page 4 of the specification, but that in an effort to expedite prosecution applicant would acquiesce to the amendment, changing the language.

#### **EXAMINER'S AMENDMENT**

- 1. An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.
- 2. Authorization for this examiner's amendment was given in a telephone interview with John A. Evans on 4/29/04. Dr. Evans faxed a copy of the authorized amendments. Winter indicated that closed claim language was required and read the below proposed changes to Dr. Evans, Dr Evans indicated that the changes were acceptable.
- 3. The application has been amended as follows:
- 4. In claim 1 now reads:
- 1. (Currently amended) A method for removing contaminants from the surface of a semiconductor substrate comprising:

Application/Control Number: 09/909,277 Page 3

Art Unit: 1746

forming an intact and contiguous film of a fluid to on a surface of said semiconductor substrate at an ambient temperature;

lowering the temperature of the fluid, thereby forming a solid layer of the fluid over the surface and entrapping contaminants within the layer; and

applying energy consisting of sonic energy having a frequency of from about 5 Hz up to megasonic values to the layer or substrate or both under such conditions as to result in separation of said solid layer including the contaminants from the surface.

## 5. Claim 23 now reads:

23. (Currently amended) A method for removing contaminants from the surface of a semiconductor substrate comprising:

forming an intact and contiguous film of a fluid on a surface of said semiconductor substrate at an ambient temperature;

lowering the temperature of the fluid by reducing the temperature of the substrate so as to form a solid layer of the fluid over the surface and entrapping contaminants within the layer; and

applying a sonic energy energy consisting of sonic energy having a frequency of from about 5 Hz up to megasonic values to the layer or substrate or both under such conditions as to result in separation of said solid layer including the contaminants from the surface.

# Reasons for Allowance

- 6. Claims 1,3-23 and 25-34, renumbered as 1-32 are allowable.
- 7. The following is an examiner's statement of reasons for allowance:

8. The prior art of record relating to an automotive rearview mirror is not longer applicable because the claims recite a semiconductor wafer, and while the cleaning may be inherent (the invention is concerned with removing ice), the rearview mirror is not generally accepted to be a semiconductor.

Page 4

- 9. The prior art of record disclosing the application of water, freezing the water film and then heating the wafer, is distinguished by the reference to: "forming a solid layer...applying energy...separation of *said* solid layer". The claims have been amended to further clarify that the layer is not melted, as is disclosed in the prior art of record.
- 10. The claims further disclose an "intact and contiguous" film. The prior art of record discloses spraying atomized water onto a frozen substrate. Figure 2 clearly indicates that the atomized water coalesces, and the specification speaks to removing particles, not a film.
- 11. Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

### Conclusion

Examiner Winter would like to thank Applicants' representative Dr. John Evans for his professionalism and courtesy.

Application/Control Number: 09/909,277

Art Unit: 1746

Page 5

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Gentle E. Winter whose telephone number is (571) 272-1310. The examiner can normally be reached on Monday-Friday 7:00-3:30.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Randy P. Gulakowski can be reached on (571) 272-1302. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Questions on access to the Private PAIR system, should be directed to the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Gentle E. Winter Examiner Art Unit 1746

April 29, 2004

RANDY GULAKOWSKI SUPERVISORY PATENT EXAMIN TECHNOLOGY CENTER 1700